

**Notice of References Cited**

Application/Control No.

10/065,662

Applicant(s)/Patent Under  
Reexamination  
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Examiner

John M. Villecco

Art Unit

2622

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-7,050,042	05-2006	Watanabe, Yoshiyuki	348/211.99
*	B	US-5,402,170	03-1995	Parulski et al.	348/211.6
*	C	US-5,479,206	12-1995	Ueno et al.	348/211.5
*	D	US-6,873,366	03-2005	Tashiro et al.	348/222.1
*	E	US-6,005,613	12-1999	Endsley et al.	348/552
*	F	US-5,754,227	05-1998	Fukuoka, Hiroki	348/231.6
*	G	US-6,493,025	12-2002	Kiriyama et al.	348/207.1
*	H	US-6,980,233	12-2005	Hirasawa, Masahide	348/207.1
*	I	US-7,161,619	01-2007	Niida et al.	348/207.11
*	J	US-6,930,709	08-2005	Creamer et al.	348/207.1
*	K	US-6,927,790	08-2005	Chandler, Rand C.	348/211.99
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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